

Application/Control No.	Applicant(s)/Patent under Reexamination
09/845,575	LAMBERT ET AL.
Examiner	Art Unit
Quoc A. Tran	2176

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Class	Subclass	Date	Examiner
709	219	8/30/2005	Ø
707	3	8/30/2005	₩)
709	217	12/22/2005	20

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
715	513	1/12/2005	***
715	526	1/12/2005	
715	501.1	1/12/2005	4

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT, US-PGPUB (see search history printout)	8/30/2005	<b>A</b>
IEEE DataBase (see search history printout)	8/30/2005	<b>A</b>
Portal USPTO, ACM Dig Lib (see search history printout)	8/30/2005	2)
USPAT, US-PGPUB (see search history printout)  + Interference search	12/22/05	#



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Class	Sub.	Date	Exmr.
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707 :	511,517 526,749 3,4,10 201,1061 102,175		
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## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

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Search Notes		

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SEARCH NO (INCLUDING SEARC		)
	DATE	EXMR
USPAT, US-PGPUB (see search history printout)	8/30/2005	0
IEEE DataBase (see search history printout)	8/30/2005	34
Portal USPTO, ACM Dig Lib (see search history printout)	8/30/2005	H
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